ICT/FCT TEST PROBES

Test Probe INGUN E-Type

E-100 214 130 A 2000

Item E-100-0037

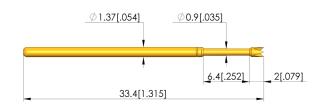




- Highest contact reliability under challenging test conditions without additional stress on the DUT: up to 25% larger contact surface between test probe and DUT
- When hitting the test surface a spring force up to 100% higher than a standard GKS is available, but the same spring force as a standard GKS is achieved at the working stroke.
- Dimensions equivalent to the standard GKS series







80 °C [176 °F]

Yes



General data

Max. temperature:

RoHS-compliant:

ICT / FCT (in-circuit test and function test Product group: Sub-product group: INGUN E-TYPE® Series: E-100 Grid: 2.54 mm [100 mil] Pad Contacting from: Magnetic: Yes Installation type: Plug-in Quick-exchange system: Yes Adjustable installation height: No Non-rotating: No Compatible receptacle(s): KS-100 Min. temperature: -40 °C [-40 °F]

Tip style data

Tip style: 14 4-point crown, self-cleaning Tip diameter: 1.3 mm [.051 in] Tip style surface: A gold Tip style material: 2 steel

Electrical data

Current load capacity / rated current: 5 A Typical resistance (Ri): 20 mOhm

Mechanical data

Total length: 33.4 mm [1.31 in] Barrel diameter: 1.37 mm [.053 in] Maximum stroke: 6.35 mm [.25 in] Spring pre-load: 1.25 N [4.49 ozf] Collar height: Spring force at working stroke: 2 N [7.19 ozf] Recommended working stroke: 4.3 mm [.169 in]

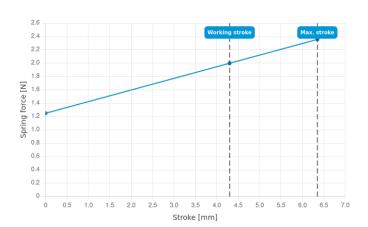
Partner for Future Technology

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Learn more about **ICT/FCT Test probes**

